

Search Notes

Application/Control No.

10/524,598

Examiner

Leon J. Harper

Applicant(s)/Patent under
Reexamination

ITABASHI ET AL.

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner
707	104.1,10, 100,4,101	6/3/2008	LJH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR